Form 1449 (Modified)	Atty. Docket No. HIT1P034/HSJ9-2003-0163US1	Application No.: Unassigned
Information Discl sure Statement By Applicant	Applicant: Hardayal Singh Gill	
1	Filing Date:	Group Art Unit:
(Use Several Sheets if Necessary)	Herewith	Unassigned

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